

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	19	reorganiz\$5 same (affect with change\$1)	USPAT	OR	OFF	2006/12/26 01:53
L2	1	reorganiz\$5 same (affect with change\$1) same (log\$1 or journal\$3)	USPAT	OR	OFF	2006/12/26 01:45
L3	6	1 and "707"/\$.ccls.	USPAT	OR	OFF	2006/12/26 01:46
L4	0	1 and "707"/202,203,204,205.ccls.	USPAT	OR	OFF	2006/12/26 01:46
L5	85	reorganization.ab.clm.	USPAT	OR	OFF	2006/12/26 01:53
L6	85	reorganization.ab.clm.ti.	USPAT	OR	OFF	2006/12/26 01:53
L7	85	reorganization.ab.clm.ti. and ((reorganiz\$6 with determin\$5 with change\$1 with affect\$1) same (log! or journal\$3))	USPAT	OR	OFF	2006/12/26 01:55
L8	0	(reorganiz\$6 same (determin\$5 with change\$1 with affect\$1) same (log! or journal\$3))	USPAT	OR	OFF	2006/12/26 01:55



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Tue, 26 Dec 2006, 2:03:17 AM EST

Edit an existing query or
compose a new query in the
Search Query Display.

Search Query Display

Select a search number (#)
to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Recent Search Queries

- | | |
|-----------|---------------------------------------------------------------------------------------------------------|
| <u>#1</u> | ((reorganization <in>metadata) <and> ((log or journal) <in>metadata))<and> (affect<in>metadata) |
| <u>#2</u> | ((reorganization<in>metadata) <and> ((log or journal) <in>metadata))<and> (change<in>metadata) |
| <u>#3</u> | ((reorganization<in>metadata) <and> ((log or journal) <in>metadata))<and> (change<in>metadata) |
| <u>#4</u> | ((reorganization<in>metadata) <and> ((log or journal) <in>metadata))<and> (change<in>metadata) |
| <u>#5</u> | ((reorganization<in>metadata) <and> ((log or journal) <in>metadata))<and> (change<in>metadata) |
| <u>#6</u> | ((reorganization <in>metadata) <and> (affect<in>metadata))<and> (change<in>metadata) |

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